

**Search Notes**

Application/Control No.

10/750,095

Examiner

Phuong KT Dinh

Applicant(s)/Patent under  
Reexamination

LEE, WEI-CHEN

Art Unit

2839

**SEARCHED**

Class	Subclass	Date	Examiner
439	630	2/20/2005	P.D
	660		
	635		
	260		
	637		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Same as above		2/20/2005	P.D

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR